

**DESCRIPTION**

The AM1005 is available in SOT-23 Package.

BVDSS	RDSON	ID
100V	91mΩ	4.5A

**APPLICATION**

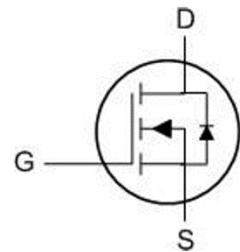
- Green Device Available
- Super Low Gate Charge
- Excellent Cdv/dt Effect Decline
- Advanced High Cell Density Trench Technology

**ORDERING INFORMATION**

Package Type	Part Number	
SOT-23 SPQ: 3,000pcs/Reel	E3	AM1005E3R
		AM1005E3VR
Note	R: Tape & Reel V: Halogen free Package	
AiT provides all RoHS products		

**PIN DESCRIPTION**

SOT-23



Pin#	Symbol	Function
1	G	Gate
2	S	Source
3	D	Drain

**ABSOLUTE MAXIMUM RATINGS**

T<sub>A</sub>=25°C Unless otherwise noted

V <sub>DS</sub> , Drain-Source Voltage	100V
V <sub>GS</sub> , Gate-Source Voltage	±20V
I <sub>D</sub> , Continuous Drain Current, V <sub>GS</sub> @ 10V	T <sub>A</sub> =25°C 4.50A
I <sub>DM</sub> <sup>(1)</sup> , Pulsed Drain Current	13.20A
P <sub>D</sub> , Power Dissipation	T <sub>A</sub> =25°C 1.50W
T <sub>J</sub> , Operating Junction Temperature Range	-55°C~+150°C
T <sub>STG</sub> , Storage Temperature Range	-55°C~+150°C
R <sub>θJA</sub> <sup>(2)</sup> , Thermal Resistance from Junction to Ambient	83.30°C/W

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C.

(2) The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.



## ELECTRICAL CHARACTERISTICS

T<sub>J</sub>=25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	100	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100V, V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1	1.65	2.50	V
Drain-Source On-State Resistance <sup>(1)</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3A	-	91	130	mΩ
		V <sub>GS</sub> =6V, I <sub>D</sub> =2A	-	105	160	
		V <sub>GS</sub> =4.50V, I <sub>D</sub> =1A	-	120	190	
<b>Dynamic Characteristics <sup>(2)</sup></b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz	-	200	-	pF
Output Capacitance	C <sub>oss</sub>		-	35	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	2.50	-	
<b>Switching Characteristics <sup>(2)</sup></b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V I <sub>D</sub> =3A	-	4	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	0.60	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	1.40	-	
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =3A, R <sub>G</sub> =3Ω, V <sub>GS</sub> =10V	-	12.50	-	ns
Turn-on Rise Time	t <sub>r</sub>		-	19.50	-	
Turn-off Delay Time	t <sub>d(off)</sub>		-	20	-	
Turn-off Fall Time	t <sub>f</sub>		-	29	-	
<b>Source- Drain Diode Characteristics</b>						
Continuous Source Drain	I <sub>S</sub>	-	-	-	4.50	A
Body Diode Voltage <sup>(1)</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =3A	-	-	1.2	V

(1) Pulse Test: PulseWidth≤300μs, Duty Cycle≤0.5%.

(2) This value is guaranteed by design hence it is not included in the production test.



## TYPICAL PERFORMANCE CHARACTERISTICS

Fig 1. Output Characteristics

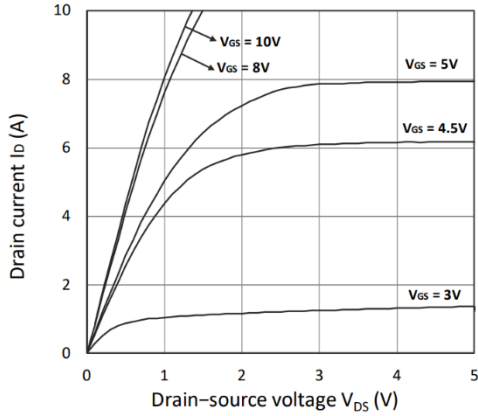


Fig 2. Transfer Characteristics

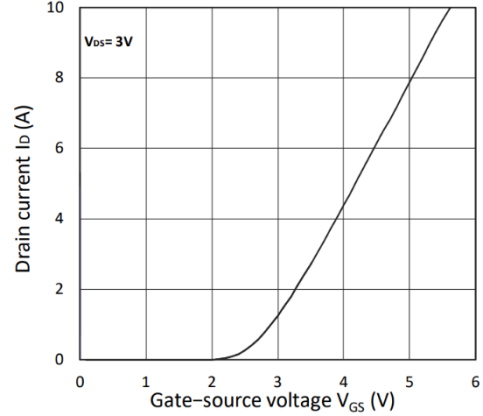


Fig 3. Forward Characteristics of Reverse

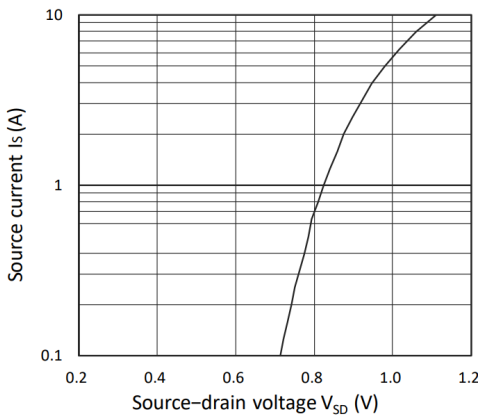


Fig 4.  $R_{DS(ON)}$  vs.  $V_{GS}$

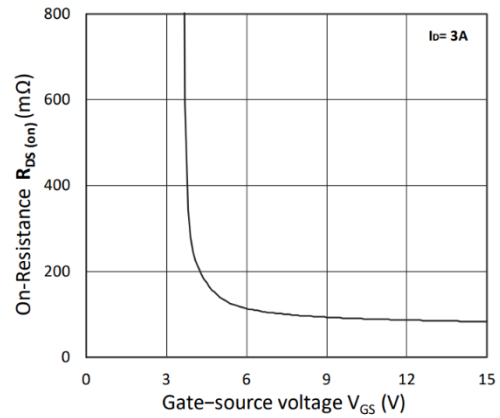


Fig 5.  $R_{DS(ON)}$  vs.  $I_D$

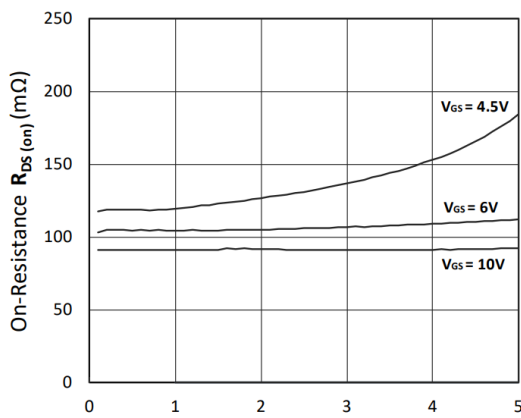


Fig 6. Normalized  $R_{DS(on)}$  vs. Temperature

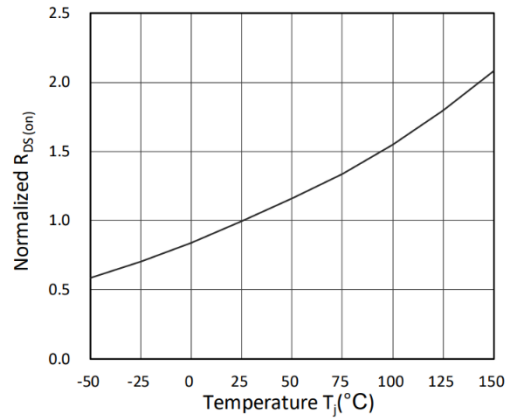




Fig 7. Capacitance Characteristics

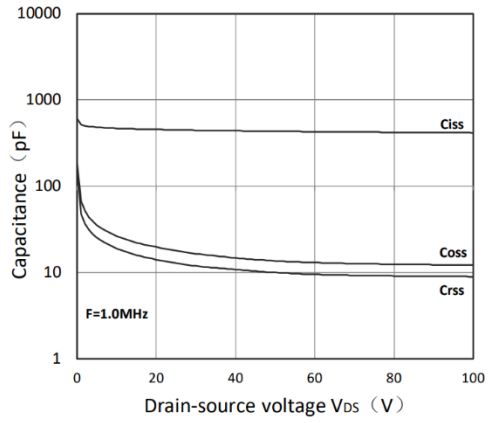
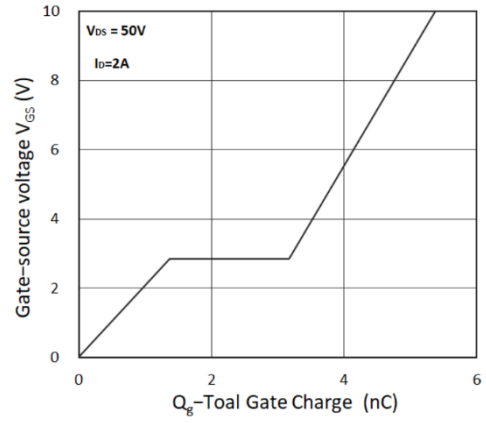


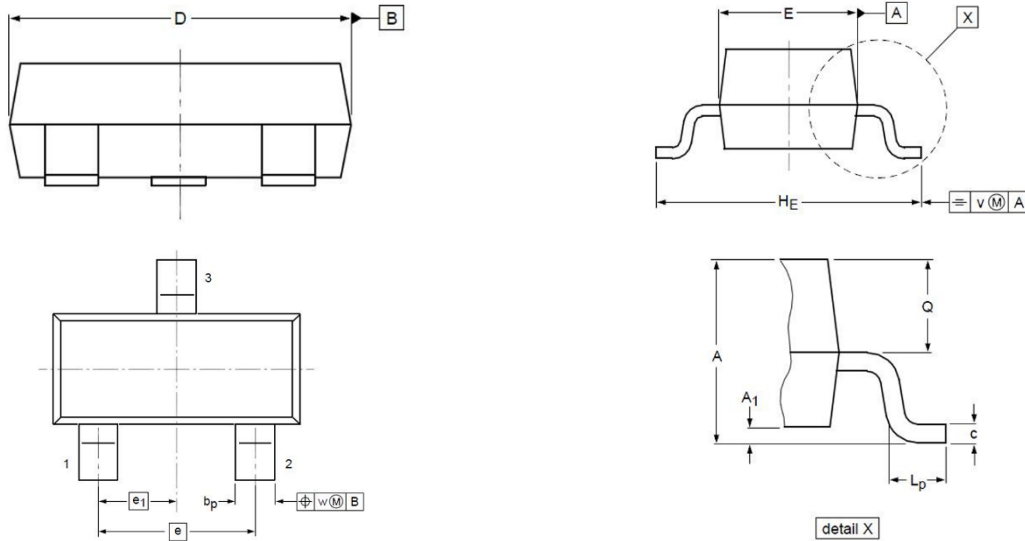
Fig 8. Gate Charge Characteristics





**PACKAGE INFORMATION**

Dimension in SOT-23 (Unit: mm)



Symbol	Millimeters (mm)	
	Min.	Max.
A	0.900	1.150
A1	0.010	0.100
$b_p$	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
e	1.900 TYP.	
$e_1$	0.950 TYP.	
$H_E$	2.250	2.550
$L_p$	0.300	0.500
Q	0.450	0.550
v	0.200 TYP.	
w	0.100 TYP.	



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